Notice of References Cited

Application/Control No. 09/532,786	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.		
Examiner	Art Unit		
Tuan M Nguyen	2828	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6232623 B1	05-2001	Morita	257/103
	В	US-6162656	12-2000	Kunisato et al	438/46
	С	US-6370176 B1	04-2002	Okumura	372-45
_ ``	D	US-6319742 B1	11-2001	Hayashi et al	438/46
	ĘΕ	US-6320209 B1	11-2001	Hata et al	257/190
	F	US-6303405 B1	10-2001	Yoshida et al	438/46
	G	US-6294440 B1	09-2001	Tsuda et al	438/479
	Н	US-			
	ı	US-		·	
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R			-		
	s			-		
	Т				1	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.